

<b>Notice of References Cited</b>	Application/Control No. 10/566,530		Applicant(s)/Patent Under Reexamination KUMAR, RAJENDRA	
	Examiner TAN TRINH		Art Unit 2618	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0148795	08-2003	Moriki, Takashi	455/566
*	B	US-2002/0082042	06-2002	Mark et al.	455/550
*	C	US-7,006,077	02-2006	Uusimaki, Matti	345/173
*	D	US-2005/0070348	03-2005	Lee et al.	455/575.4
*	E	US-2003/0064688	04-2003	Mizuta et al.	455/90
*	F	US-2005/0113157	05-2005	Jaakola, Mikael	455/575.6
*	G	US-2007/0287381	12-2007	Hulvey, Robert W.	455/041.2
*	H	US-2007/0146330	06-2007	Nguyen et al.	345/169
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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